

MOS FIELD EFFECT TRANSISTOR 2SJ605

SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SJ605 is P-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

Super low on-state resistance:

RDS(on)1 = 20 m Ω MAX. (Vgs = -10 V, ID = -33 A)

 $R_{DS(on)2} = 31 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -4.0 \text{ V, ID} = -33 \text{ A)}$

- Low input capacitance
- ★ $C_{iss} = 4600 \text{ pF TYP.}$ (VDS = -10 V, VGS = 0 A)
 - Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ605	TO-220AB
2SJ605-S	TO-262
2SJ605-ZJ	TO-263
2SJ605-Z	TO-220SMD ^{Note}

Note TO-220SMD package is produced only in Japan.

(TO-220AB)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vss = 0 V)	Voss	-60	V
Gate to Source Voltage (V _{DS} = 0 V)	Vgss	∓ 20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	oc) ∓ 65	
Drain Current (pulse) Note1	D(pulse)	∓ 200	Α
Total Power Dissipation (Tc = 25°C)	PT	100	W
Total Power Dissipation (T _A = 25°C)	Рт	1.5	W
Channel Temperature	T_ch	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C
Single Avalanche Current Note2	las	-45	Α
Single Avalanche Energy Note2	Eas	203	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = -30 V, R_G = 25 Ω , V_{GS} = -20 \rightarrow 0 V



(TO-262)



(TO-263, TO-220SMD)



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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

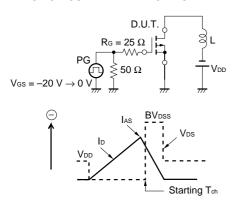


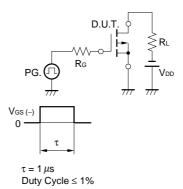
ELECTRICAL CHARACTERISTICS (TA = 25°C)

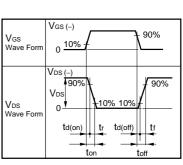
	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Zero Gate Voltage Drain Current	IDSS	V _{DS} = -60 V, V _{GS} = 0 V			-10	μΑ
	Gate Leakage Current	Igss	$V_{GS} = \mp 20 \text{V}, V_{DS} = 0 \text{V}$			∓ 10	μΑ
*	Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-1.5	-2.0	-2.5	V
	Forward Transfer Admittance	y _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -33 \text{ A}$	30	59		S
	Drain to Source On-state Resistance	RDS(on)1	Vgs = -10 V, ID = -33 A		17	20	mΩ
		RDS(on)2	$V_{GS} = -4.0 \text{V}, I_{D} = -33 \text{A}$		22	31	mΩ
	Input Capacitance	Ciss	V _{DS} = −10 V		4600		pF
*	Output Capacitance	Coss	Vgs = 0 V		820		pF
	Reverse Transfer Capacitance	Crss	f = 1 MHz		330		pF
	Turn-on Delay Time	td(on)	V _{DD} = -30 V, I _D = -33 A		15		ns
	Rise Time	tr	Vgs = -10 V		14		ns
	Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		100		ns
	Fall Time	t f			58		ns
	Total Gate Charge	Q _G	V _{DD} = -48 V		87		nC
	Gate to Source Charge	Qgs	Vgs = -10 V		15		nC
	Gate to Drain Charge	Q _{GD}	ID = -65 A		22		nC
*	Body Diode Forward Voltage	V _{F(S-D)}	IF = 65 A, VGS = 0 V		1.0		V
*	Reverse Recovery Time	trr	IF = 65 A, VGS = 0 V		53		ns
*	Reverse Recovery Charge	Qrr	$di/dt = 100 A/\mu s$		110		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

★ TEST CIRCUIT 2 SWITCHING TIME



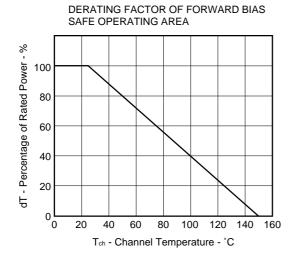


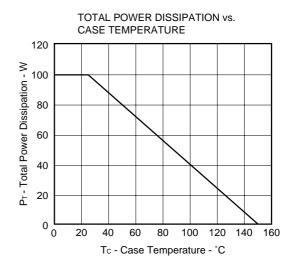


TEST CIRCUIT 3 GATE CHARGE

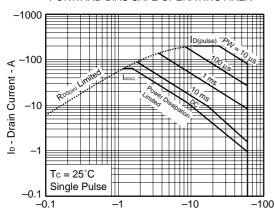


TYPICAL CHARACTERISTICS (TA = 25°C)



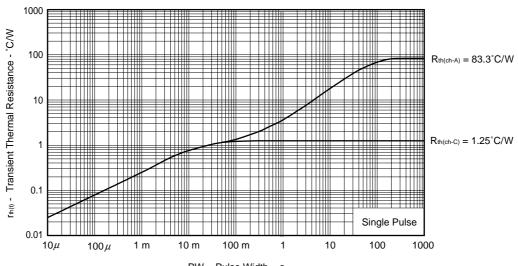


FORWARD BIAS SAFE OPERATING AREA



V_{DS} - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

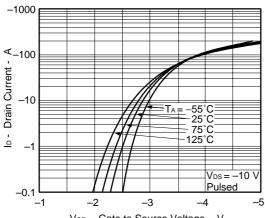


PW - Pulse Width - s

3

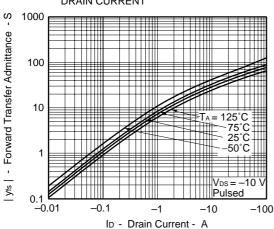


FORWARD TRANSFER CHARACTERISTICS

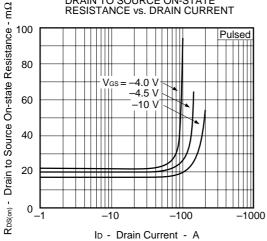


V_{GS} - Gate to Source Voltage - V

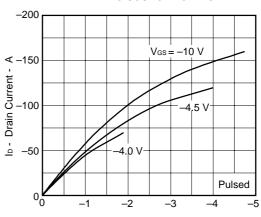
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

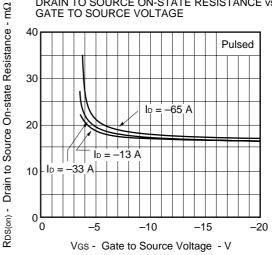


DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

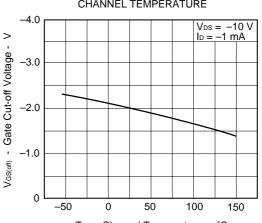


V_{DS} - Drain to Source Voltage - V

DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

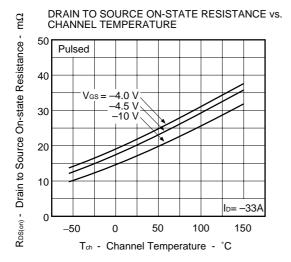


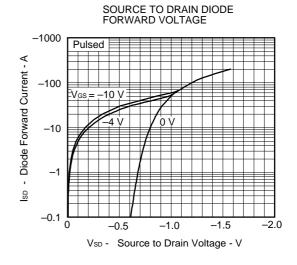
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

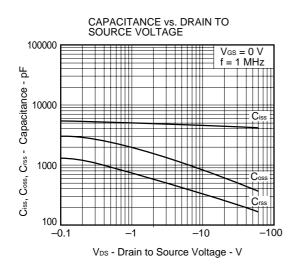


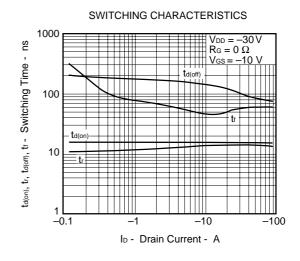
Tch - Channel Temperature - °C

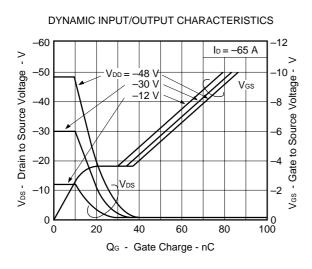


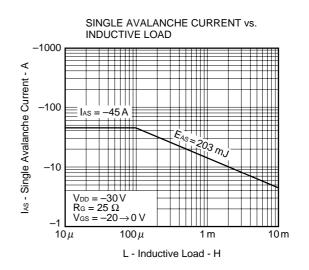






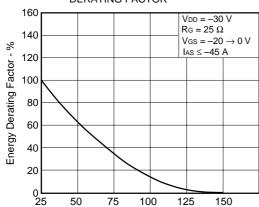






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SINGLE AVALANCHE ENERGY DERATING FACTOR

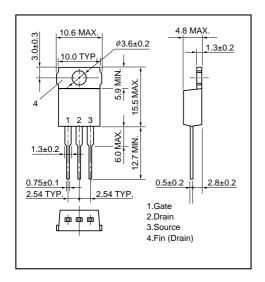


Starting Tch - Starting Channel Temperature - °C

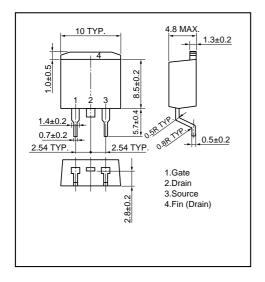


★ PACKAGE DRAWINGS(Unit: mm)

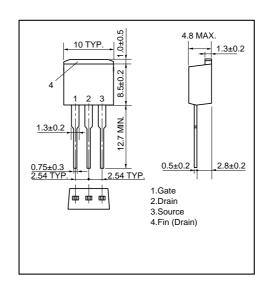
1) TO-220AB(MP-25)



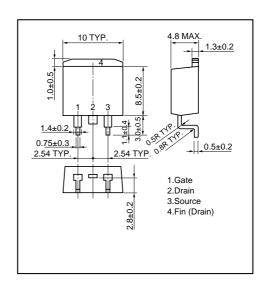
3) TO-263 (MP-25ZJ)



2) TO-262(MP-25 Fin Cut)

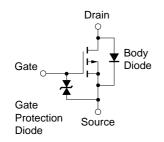


4) TO-220SMD(MP-25Z)^{Note}



Note This package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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